

Notice of References Cited	Application/Control No. 10/786,372	Applicant(s)/Patent Under Reexamination ZHENG ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0091862	05-2003	Tokito et al.	428/690
	B	US-6,444,334	09-2002	Doi et al.	428/690
	C	US-6,630,254	10-2003	Leclerc et al.	428/690
	D	US-6,830,832	12-2004	Oguma et al.	428/690
	E	US-2001/0053843	12-2001	Pei, Qibing	528/422
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08-113622	05-1996	Japan	Fujiyama et al.	-----
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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